## Application/Control No. Applicant(s)/Patent Under Reexamination 10/605,234 CHANG ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2823 Khiem D. Nguyen **U.S. PATENT DOCUMENTS** Document Number Country Code-Number-Kind Code Date Name Classification MM-YYYY US-6,929,998 08-2005 Chen et al. Α 438/246 \* US-6,872,621 В 03-2005 Wu, Yung-Hsien 438/243 С US-6,544,856 04-2003 Morhard et al. 438/392 US-D US-Ε US-F US-G US-Н USı US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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